

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination LIU ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	John L. Vossen and Werner Kern, Thin Film Processes !!, Copyright 1991, Academic Press, page 526
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